

2

Sheet 1 of

Form 1449*

INFORMATION DISCLOSURE STATEMENT

BY APPLICANT
(Use several sheets if necessary)

Atty. Docket No.: 303.326US1

Serial No. 08/903,486

Applicant: Leonard Forbes et al.

Filing Date: July 29, 1997

Group: 2811

U.S. PATENT DOCUMENTS

*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
1./104						
W.M.	. 4,113,515	09/12/1978	Kooi, E., et al.	148	1.5	03/29/76
	. 5,858,811	01/12/1999	Tohyama, S.	438	75	01/15/97
	6,144,581	11/07/2000	Diorio, C.J., et al.	365	185.03	11/30/98
1/1/1/	6,163,066	12/19/2000	Forbes, L., et al.	257	632	08/24/98

FOREIGN PATENT DOCUMENTS

**Examiner						i'' Translation
initial.	Document Number	Date	Country	Class	Subclass	Yes No
Dr ANC 1	. 01-115162	05/08/1989	Japan	HO1L	29/78	1000元
	. 0291951	11/23/1988	European	H01L	29/64	
. ——	. 04-056769	02/24/1992	Japan	C23C	16/32	المستحمد والمراجع
	. 0681333	08/11/1995	European	H01L	29/788	<i>p</i> = 1
	. 07-115191	05/02/1995	Japan	H01L	29/78	VED 2001 CENTER
	62-122275	06/03/1987	Japan	HO1L	27/78	
	63-181473	07/26/1988	Japan	HO1L	29/78	言当じ
	63-219172	09/12/1988	Japan	HO1L	29/78	
WM.	63-289960	11/28/1988	Japan	H01L	29/78	28
1()			-			00

**Examiner

Initial

OTHER DOCUMENTS

(Including Author, Title, Date, Pertinent Pages, Etc.)

W.M.

Zirinsky, S., et al., "Electrical Resistivity of Amorphous Silicon Resistor Films", Extended Abstracts of the Spring Meeting of the Electrochemical Society, Washington, DC, pp. 147-149, (1971)

Examiner William Mintel

Date Considered

6/12/01

**EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.